

Search Notes

Application/Control No.

10/736,432

Examiner

Duc M. Nguyen

Applicant(s)/Patent under
Reexamination

DEMIR ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	234.1 234.2 239.1	11/8/2004	DN
	226.1 295		
	296 304		
	249.1		
	250.1		
375	319		
	345	11/8/2004	DN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	11/8/2004	DN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner